Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,212	TAKAISHI, MASARU	
Examiner	Art Unit	
Fernando L. Toledo	2823	

SEARCHED			
Class	Subclass	Date	Examiner
438	597, 660, 669, 672, 674, 675	7/23/2005	FLT
438	688	7/23/2005	FLT
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
EAST: see attached search	7/23/2005	FLT
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